Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/636,783	YAMASHITA ET AL.
Examiner	Art Unit
HOAN C. NGUYEN	2871

	SEAR	CHED	- "
Class	Subclass	Date	Examiner
345	155	8/24/2005	CHN
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
update search in US_PGPUB, USPAT, EPO and JPO	8/24/2005	CHN	
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